

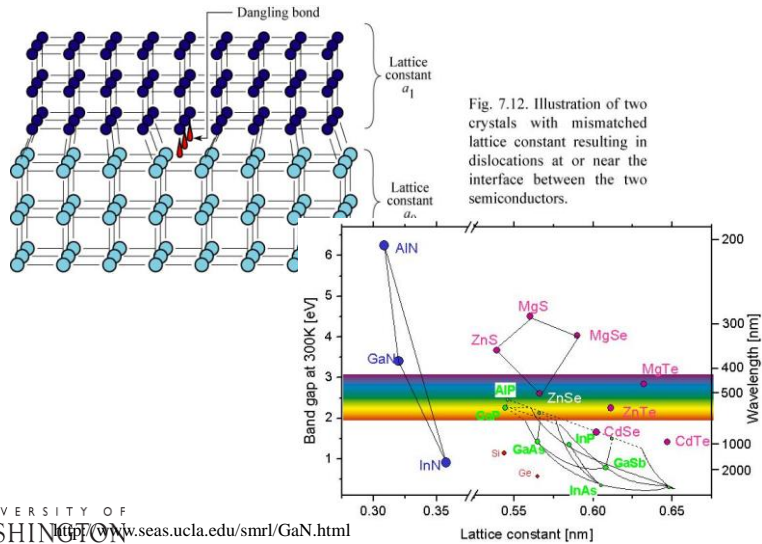
EPITAXY

- Epitaxy is a very special case of thin-film deposition.
 - The deposited film is single crystalline.
 - The deposited layer registers the crystalline information from the substrate.
 - The crystal lattices of the film and the substrate must be identical or closely matching.

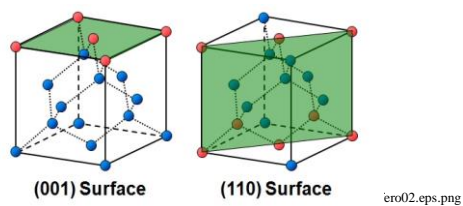
HETEROEPITAXY/EPITAXIAL GROWTH

- Homoepitaxy:
 - Substrate crystal is the same material of the grown thin film.
 - The growing crystal layer maintain the crystal structure and orientation of the substrate.
- The methods: chemical vapor (vapor-phase) deposition (CVD), liquid-phase deposition (LPE), solid-phase deposition (MBE)
- Heteroepitaxy:
 - Epitaxial layers are different materials from substrate.
 - The growing crystal layer maintain the crystal structure and orientation of the substrate, if the lattice structure and constant a match for the two materials.
 - Buffer layer: a thin low temperature growth film between substrate and epitaxial thin film to reduce misfit dislocations and stress.

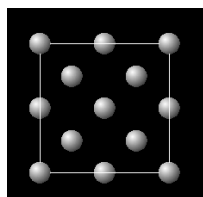
HETEROEPITAXY/LATTICE MATCHING IN EPITAXIAL GROWTH



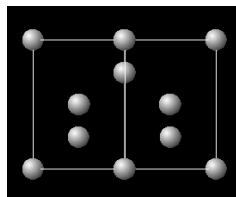
HETEROEPITAXY/LATTICE MATCHING IN EPITAXIAL GROWTH



View in $\langle 100 \rangle$ direction

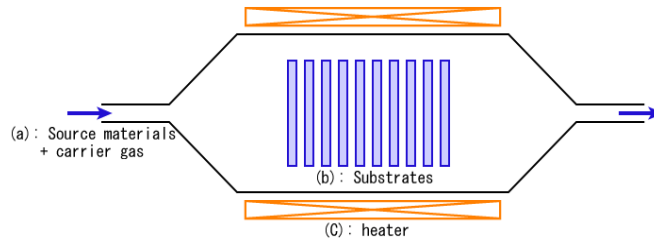


View in $\langle 110 \rangle$ direction



EPITAXY/VAPOR-PHASE EPITAXY (CVD)

- VPE is a particular important source of semiconductor material.
- Advantages:
 - Low temperature and high purity growth.



Reaction chamber: Reactor

Heating: rf heating or W halogen lamps

<http://en.wikipedia.org/wiki/>

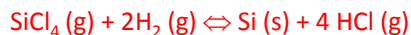
EPITAXY/VAPOR-PHASE EPITAXY (CVD)

Use Si VPE as an example:

- Dichlorosilane at 1150 °C



- A gas phase of silicon tetrachloride (SiCl_4) reacts with H_2 , at 1250 °C



- This reaction is reversible, and cleaning is possible with HCl when the reaction proceeds from right to left.
- Above process temperatures are very high and undesirable for certain fabrication processes.
- Use silane as the Si source at 500 – 1000 °C



CVD/CVD POLYSILICON

CVD Poly-silicon

- Pyrolysis of silane: $\text{SiH}_4 \rightarrow \text{Si} + 2\text{H}_2$
 - LPCVD Process 1: 100% SiH_4 , 0.2 - 1.0 torr
 - LPCVD Process 2: 30% SiH_4 in nitrogen, 0.2 - 1.0 torr
 - deposition rates: 10 - 20 nm/min
 - APCVD: 3% SiH_4 in nitrogen
- Amorphous (< 600°C) or polycrystalline (> 600°C)